

PTO/SB/08a/b (08-03)

Approved for use through 07/31/2006. OMB 0651-0031  
U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449A/B/PTO

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet

1

of

3

**Complete if Known**

Application Number	10/765,911		
Filing Date	January 29, 2004		
First Named Inventor	Kristy A. Campbell		
Art Unit	N/A		
Examiner Name	Not Yet Assigned		
Attorney Docket Number	M4065.0937/P937		

**U.S. PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
TN	AA	US-6,218,718	4/2001	Gregg et al.	
	AB	US-6,304,481	10/2001	Hurt	
	AC	US-6,061,265	5/2000	Hannah	
	AD	US-5,530,263	6/1996	DiVincenzo	
TN	AE	US-6,052,519	4/2000	Gates et al.	

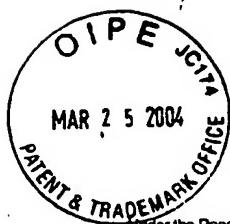
**FOREIGN PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>3</sup>
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)				

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. <sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 601.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached. \*

**NON PATENT LITERATURE DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
TN	CA	A. E. BOTHA et al.; "Electron-spin polarization in symmetric type-II quantum wells from bulk inversion asymmetry" The American Physical Society, Physical Review B67, 195334 pp. 1-8 (2003).	
	CB	KRISTY A. CAMPBELL, et al.; "Parallel Polarization EPR Characterization of the Mn(III) Center of Oxidized Manganese Superoxide Dismutase" J. Am. Chem. Soc., 121, pp. 4714-4715 (1999).	
	CC	SHUNICHI FUKUZUMI, et al.; "Photochemical and Electrochemical Properties of Zinc Chlorin - C <sub>60</sub> Dyad as Compared to Corresponding Free-Base Chlorin - C <sub>60</sub> , Free-Base Porphyrin - C <sub>60</sub> , and Zinc Porphyrin - C <sub>60</sub> Dyads" J. Am. Chem. Soc., 123, pp. 10676-10683, (2001).	
	CD	L. B. GLEBOV, et al.; "Magneto-induced microwave conductivity in Mn <sup>2+</sup> - doped silicate glass" Journal of Non-Crystalline Solids 265, pp. 181-184, (2000).	
	CE	O. KAHN, et al.; "Spin-Transition Polymers: From Molecular Materials Toward Memory Devices", Science, Vol. 279, pp. 44-48 (January 2, 1998).	
	CF	FATIH KOCER, et al.; "A New Approach In NanoScale Electronics: Spin-FET (Field Effect Transistor) and Spin-Based Memory Architectures,"< <a href="http://www.personal.engine.unich.edu/w/pualized/spin.pdf">www.personal.engine.unich.edu/w/pualized/spin.pdf</a> > (accessed prior to 1/29/04).	
	CG	YUJI KUBO, et al.; "Chirality-Transfer Control Using a Heterotopic Zinc (II) Porphyrin Dimer," J. Am. Chem. Soc. 123, pp. 12700-12701, (2001).	
	CH	Physics Laboratory, "Fourier-Transform Microwave Spectroscopy for Chemical Analysis," < <a href="http://physics.nist.gov/Divisions/Div844/facilities/ftmw/ftmw.html">http://physics.nist.gov/Divisions/Div844/facilities/ftmw/ftmw.html</a> > (accessed 2/24/2003).	
TN	CI	QILIANG LI; "Capacitance and conductance characterization of ferrocene-containing self-assembled monolayers on silicon surfaces for memory applications," Applied Physics Letters, Volume 81, Number 8, pp. 1494-1496, (August 19, 2002).	



MAR 25 2004

PTO/SB/08a/b (08-03)

Approved for use through 07/31/2008. OMB 0651-0031  
U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449A/B/PTO

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet

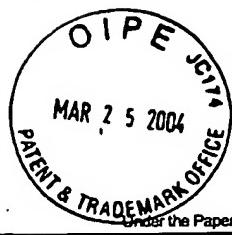
2

of

3

		<i>Complete If Known</i>	
Application Number	10/765,911		
Filing Date	January 29, 2004		
First Named Inventor	Kristy A. Campbell		
Art Unit	N/A		
Examiner Name	Not Yet Assigned		
Attorney Docket Number	M4065.0937/P937		

TTW	CJ	PAUL A. LIDDELL, et al.; "Photonic Switching of Photoinduced Electron Transfer in a Dithienylethene-Porphyrin-fullerene Triad Molecule," J. Am. Chem. Soc. 124, pp. 7668-7669, (2002).	
	CK	S.E. LOFLAND, et al.; "Giant microwave magneto-impedance in a single crystal of La <sub>0.7</sub> Sr <sub>0.3</sub> MnO <sub>3</sub> : The effect of ferromagnetic antiresonance," J. Appl. Phys. 80(6), pp. 3592-3594, (September 15, 1996).	
	CL	S. LUDWIG, et al.; "Direct Coupling of Magnetic Fields to Tunneling Systems in Glasses," Physical Review Letters, Volume 88, Number 7, pp. 075501-1-4, (February 18, 2002).	
	CM	J.A. MAJEWSKI, et al.; "First principles study of spin-electronics: Zero-field spin-splitting in superlattices," < <a href="http://www.wsi.tu-muenchen.de/research/annual_reports/rep00/pdfs/24.pdf">www.wsi.tu-muenchen.de/research/annual_reports/rep00/pdfs/24.pdf</a> > (accessed prior to 1/29/04).	
	CN	IAN J. McNAUGHT, et al.; "Microwave Spectroscopy Tutor," < <a href="http://jchemed.chem.wisc.edu/JCESoft/Issues/Series_B/8B2/prog2-8B2.html">http://jchemed.chem.wisc.edu/JCESoft/Issues/Series_B/8B2/prog2-8B2.html</a> > (accessed 2/24/2003).	
	CO	A.N. Medina, et al.; "Resonant microwave cavity response of amorphous ribbons," J. Appl. Phys. 79(8), pp. 5462-64, (April 15, 1996).	
	CP	RYO MIYAMOTO, et al.; "Interplanar interactions in the triplet dimmers of Zn and metal free complexes of crowned porphyrin and phthalocyanine studied by time-resolved electron paramagnetic resonance," Coordination Chemistry Reviews, 132, pp. 57-62, (1994).	
	CQ	P. GIRI PRAKASH, et al.; "EPR and optical absorption studies of Mn <sup>2+</sup> ions in alkali borotellurite glasses," Modern Physics Letters B, Vol. 16, Nos. 5 & 6, pp. 143-159, World Scientific Publishing Company, (2002).	
	CR	R.R. RAKHIMOV, et al.; "Microwave response near zero magnetic field in transition-metal-doped silicate glasses," Applied Physics Letters, Volume 76, Number 6, pp. 751-753, (February 7, 2000).	
	CS	JOHN ROBBLEE; "Electron Paramagnetic Resonance" Berkeley Spectroscopy Club," < <a href="http://spectroscopy.161.gov/EPR-Robblee.pdf">http://spectroscopy.161.gov/EPR-Robblee.pdf</a> > (accessed April 18, 2001).	
	CT	M.A. ROWE, et al.; "A Hyperfine Measurement in Laser Trapped Radioactive <sup>23</sup> Na," < <a href="http://weak0.physics.berkeley.edu/weakint/annual.reports/1997/21Na.NSD1997.pdf">http://weak0.physics.berkeley.edu/weakint/annual.reports/1997/21Na.NSD1997.pdf</a> > (accessed prior to 1/29/04).	
	CU	POUYA VALIZADEH; "New Approaches in Spin-Electronics: High current gain spin-based HBT and Memory application for the spin-FET," III-V Integrated Circuits and Devices Group, Solid-State Electronics Laboratory, University of Michigan (pub. date not known).	
	CV	SUNG IK YANG et al.; "Interplay of Orbital Tuning and Linker Location in Controlling Electronic Communication in Porphyrin Arrays," American Chemical Society, pp. 4008-18, (1999).	
	CW	DAE HWAN YOON, et al.; "Electrical Conduction through Linear Porphyrin Arrays," J. Am. Chem. Soc. 125, pp. 11062-11064, (August 15, 2003).	
	CX	Chemedu, "Crystal Field Theory" < <a href="http://chemed.chem.purdue.edu/genchem/topicreview/bp/ch12/crystal.html">http://chemed.chem.purdue.edu/genchem/topicreview/bp/ch12/crystal.html</a> >, (accessed 6/23/2003).	
	CY	U. Wimona, "Crystal Field Theory (CFT), An Introduction," < <a href="http://wwwchem.uwimona.edu.jm;1104/courses/CFT.html">http://wwwchem.uwimona.edu.jm;1104/courses/CFT.html</a> > (accessed 6/23/2003).	
	CZ	*BioChem, "Electromagnetic Radiation," < <a href="http://biochem.unl.edu/ragsdale/EPRspectroscopy/sld002.html">http://biochem.unl.edu/ragsdale/EPRspectroscopy/sld002.html</a> > (accessed 7/3/2003).	
	CA1	"ESR Spectroscopy", < <a href="http://www.mlib.cnr.it/marble/esr.html">http://www.mlib.cnr.it/marble/esr.html</a> > (accessed 7/16/2003).	
	CB1	Frontier Scientific, "Prophyrins," Frontier Scientific, < <a href="http://www.frontiersci.com/prophyrins.html">http://www.frontiersci.com/prophyrins.html</a> > (accessed 11/15/2003).	
	CC1	Net BioChem, "Porphyrins" Hemeandiron, < <a href="http://www.porphyrin.net/Heme_Ironporphyrins/_porphymain.html">http://www.porphyrin.net/Heme_Ironporphyrins/_porphymain.html</a> > (accessed 11/15/2003).	



Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

PTO/SB/08a/b (08-03)

Approved for use through 07/31/2008. OMB 0651-0031  
U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

Substitute for form 1449A/B/PTO				Complete if Known	
				Application Number	10/765,911
				Filing Date	January 29, 2004
				First Named Inventor	Kristy A. Campbell
				Art Unit	N/A
				Examiner Name	Not Yet Assigned
Sheet	3	of	3	Attorney Docket Number	M4065.0937/P937

TJN	CD1	U. WA, "Section 4: Metal-Ligand Interactions and "Reactions of Coordinated Ligands," < <a href="http://www.chem.uwa.edu.au/enrolled_students/2nd_year_Chem_Inorg_Section/sect4/sect.&gt;">http://www.chem.uwa.edu.au/enrolled_students/2nd_year_Chem_Inorg_Section/sect4/sect.&gt;<td></td></a>	
	CE1	Univ. Arizona, "Microwave Spectroscopy," < <a href="http://www.chem.arizona.edu/faculty/kuko/research/mwspec/spectra/spectra.htm">http://www.chem.arizona.edu/faculty/kuko/research/mwspec/spectra/spectra.htm</a> > (accessed 2/24/2003).	
	CF1	BioChem, "The Mineral Perovskite," < <a href="http://mineral.galleries.com/minerals/oxides/perovvski/perovski.htm">http://mineral.galleries.com/minerals/oxides/perovvski/perovski.htm</a> > (accessed 11/15/2003).	
	CG1	BioChem, "Spin-Spin Interaction," < <a href="http://biochem.unl.edu/ragsdale/EPRspectroscopy/sld032.html">http://biochem.unl.edu/ragsdale/EPRspectroscopy/sld032.html</a> > (accessed 7/16/2003).	
TJN	CH1	U. Alabama, < <a href="http://bama.ua.edu/Kshaughn/ch609/notes/3-legal survey">http://bama.ua.edu/Kshaughn/ch609/notes/3-legal survey</a> > (accessed prior to 1/29/04).	

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup>Applicant's unique citation designation number (optional). <sup>2</sup>Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature		Date Considered	10/24/05
--------------------	--	-----------------	----------



PTO/SB/08a/b (08-03)

Approved for use through 07/31/2006. OMB 0651-0031  
U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449A/B/PTO

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet

1

of

3

**Complete if Known**

Application Number	10/765,911-Conf. #2647
Filing Date	January 29, 2004
First Named Inventor	Kristy A. Campbell
Art Unit	2818
Examiner Name	Not Yet Assigned

Attorney Docket Number M4065.0937/P937

**U.S. PATENT DOCUMENTS**

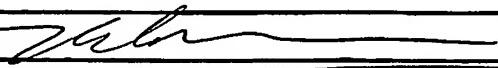
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
TN	A	US 2004/0035401	2/2004	Ramachandran et al.	
	B	US 2003/0212724	11/2003	Ovshinsky et al.	
	C	US 2003/0048744	3/2003	Ovshinsky et al.	
	D	US 2003/0212725	11/2003	Ovshinsky et al.	
	E	US RE 37,259E	7/2001	Ovshinsky	
	F	US 3,271,591	9/1966	Ovshinsky	
	G	US 3,961,314	6/1976	Klose et al.	
	H	US 3,966,317	6/1976	Wacks et al.	
	I	US 3,983,542	11/1976	Ovshinsky	
	J	US 3,988,720	10/1976	Ovshinsky	
	K	US 4,177,474	12/1979	Ovshinsky	
	L	US 4,267,261	5/1981	Hallman et al.	
	M	US 4,597,162	7/1986	Johnson et al.	
	N	US 4,608,296	8/1986	Keem et al.	
	O	US 4,637,895	1/1987	Ovshinsky et al.	
	P	US 4,646,266	2/1987	Ovshinsky et al.	
	Q	US 4,664,939	5/1987	Ovshinsky	
	R	US 4,668,968	5/1987	Ovshinsky et al.	
	S	US 4,670,763	6/1987	Ovshinsky et al.	
	T	US 4,673,957	6/1987	Ovshinsky et al.	
	U	US 4,678,679	7/1987	Ovshinsky	
	V	US 4,696,758	9/1987	Ovshinsky et al.	
	W	US 4,698,234	10/1987	Ovshinsky et al.	
	X	US 4,710,899	12/1987	Young et al.	
	Y	US 4,728,406	3/1988	Banerjee et al.	
	Z	US 4,737,379	4/1988	Hudgens et al.	
	A1	US 4,766,471	8/1988	Ovshinsky et al.	
	B1	US 4,769,338	9/1988	Ovshinsky et al.	
	C1	US 4,775,425	10/1988	Guha et al.	
	D1	US 4,788,594	11/1988	Ovshinsky et al.	
	E1	US 4,809,044	2/1989	Pryor et al.	
	F1	US 4,818,717	4/1989	Johnson et al.	
	G1	US 4,843,443	6/1989	Ovshinsky et al.	
	H1	US 4,845,533	7/1989	Pryor et al.	
	I1	US 4,853,785	8/1989	Ovshinsky et al.	
	J1	US 4,891,330	1/1990	Guha et al.	
	K1	US 5,128,099	7/1992	Strand et al.	
	L1	US 5,159,661	10/1992	Ovshinsky et al.	
	M1	US 5,166,758	11/1992	Ovshinsky et al.	
	N1	US 5,177,567	1/1993	Klersy et al.	
	O1	US 5,296,716	3/1994	Ovshinsky et al.	
	P1	US 5,335,219	8/1994	Ovshinsky et al.	

Examiner Signature		Date Considered	10/24/05
--------------------	--	-----------------	----------

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449A/B/PTO				Complete if Known	
				Application Number	10/765,911-Conf. #2647
				Filing Date	January 29, 2004
				First Named Inventor	Kristy A. Campbell
				Art Unit	2818
				Examiner Name	Not Yet Assigned
Sheet	2	of	3	Attorney Docket Number	M4065.0937/P937

Q1	US 5,359,205	10/1994	Ovshinsky
R1	US 5,341,328	8/1994	Ovshinsky et al.
S1	US 5,406,509	4/1995	Ovshinsky et al.
T1	US 5,414,271	5/1995	Ovshinsky et al.
U1	US 5,534,711	7/1996	Ovshinsky et al.
V1	US 5,534,712	7/1996	Ovshinsky et al.
W1	US 5,536,947	7/1996	Klersy et al.
X1	US 5,543,737	8/1996	Ovshinsky
Y1	US 5,591,501	1/1997	Ovshinsky et al.
Z1	US 5,596,522	1/1997	Ovshinsky et al.
A2	US 5,687,112	11/1997	Ovshinsky
B2	US 5,694,054	12/1997	Ovshinsky et al.
C2	US 5,714,768	2/1998	Ovshinsky et al.
D2	US 5,825,046	10/1998	Czubatyj et al.
E2	US 5,912,839	6/1999	Ovshinsky et al.
F2	US 5,933,365	8/1999	Klersy et al.
G2	US 6,011,757	1/2000	Ovshinsky
H2	US 6,087,674	7/2000	Ovshinsky et al.
I2	US 6,141,241	10/2000	Ovshinsky et al.
J2	US 6,339,544	1/2002	Chiang et al.
K2	US 6,404,665	6/2002	Lowery et al.
L2	US 6,429,064	8/2002	Wicker
M2	US 6,437,383	8/2002	Xu
N2	US 6,462,984	10/2002	Xu et al.
O2	US 6,480,438	11/2002	Park
P2	US 6,487,113	11/2002	Park et al.
Q2	US 6,501,111	12/2002	Lowery
R2	US 6,507,061	1/2003	Hudgens et al.
S2	US 6,511,862	1/2003	Hudgens et al.
T2	US 6,511,867	1/2003	Lowery et al.
U2	US 6,512,241	1/2003	Lai
V2	US 6,514,805	2/2003	Xu et al.
W2	US 6,531,373	3/2003	Gill et al.
X2	US 6,534,781	3/2003	Dennison
Y2	US 6,545,287	4/2003	Chiang
Z2	US 6,545,907	4/2003	Lowery et al.
A3	US 6,555,860	4/2003	Lowery et al.
B3	US 6,563,164	5/2003	Lowery et al.
C3	US 6,566,700	5/2003	Xu
D3	US 6,567,293	5/2003	Lowery et al.
E3	US 6,569,705	5/2003	Chiang et al.
F3	US 6,570,784	5/2003	Lowery
G3	US 6,576,921	6/2003	Lowery
H3	US 6,586,761	7/2003	Lowery
I3	US 6,589,714	7/2003	Maimon et al.

Examiner Signature		Date Considered	6/24/05
--------------------	---	-----------------	---------

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449A/B/PTO					<b>Complete If Known</b>	
					Application Number	10/765,911-Conf. #2647
					Filing Date	January 29, 2004
					First Named Inventor	Kristy A. Campbell
					Art Unit	2818
					Examiner Name	Not Yet Assigned
Sheet	3	of	3		Attorney Docket Number	M4065.0937/P937

✓ J3	US 6,590,807	7/2003	Lowery	
✓ K3	US 6,593,176	7/2003	Dennison	
✓ L3	US 6,597,009	7/2003	Wicker	
✓ M3	US 6,605,527	8/2003	Dennison et al.	
✓ N3	US 6,613,604	9/2003	Maimon et al.	
✓ O3	US 6,621,095	9/2003	Chiang et al.	
✓ P3	US 6,625,054	9/2003	Lowery et al.	
✓ Q3	US 6,642,102	11/2003	Xu	
✓ R3	US 6,646,297	11/2003	Dennison	
✓ S3	US 6,649,928	11/2003	Dennison	
✓ T3	US 6,667,900	12/2003	Lowery et al.	
✓ U3	US 6,671,710	12/2003	Ovshinsky et al.	
✓ V3	US 6,673,648	1/2004	Lowrey	
✓ W3	US 6,673,700	1/2004	Dennison et al.	
✓ X3	US 6,674,115	1/2004	Hudgens et al.	
✓ Y3	US 6,687,427	2/2004	Ramalingam et al.	
✓ Z3	US 6,690,026	2/2004	Peterson	
✓ A4	US 6,696,355	2/2004	Dennison	
✓ B4	US 6,687,153	2/2004	Lowery	
✓ C4	US 6,707,712	3/2004	Lowery	
✓ D4	US 6,714,954	3/2004	Ovshinsky et al.	

<b>FOREIGN PATENT DOCUMENTS</b>					
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code <sup>2</sup> -Number-Kind Code <sup>3</sup> (if known)			
					T <sup>4</sup>

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. <sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 801.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

<b>NON PATENT LITERATURE DOCUMENTS</b>					
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T <sup>2</sup>

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup>Applicant's unique citation designation number (optional). <sup>2</sup>Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature		Date Considered	10/24/05
--------------------	---	-----------------	----------